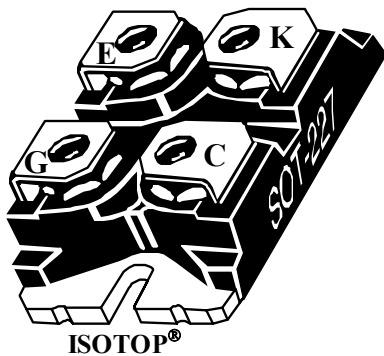
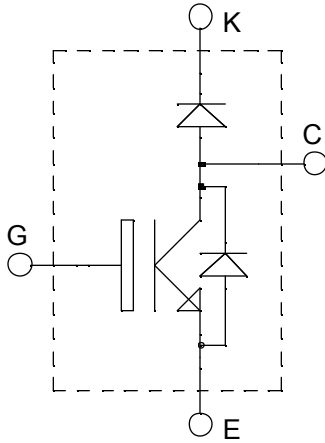


**ISOTOP[®] Boost chopper
NPT IGBT**
 $V_{CES} = 600V$
 $I_C = 50A @ T_c = 90^{\circ}C$

Application

- AC and DC motor control
- Switched Mode Power Supplies
- Power Factor Correction
- Brake switch

Features

- Non Punch Through (NPT) THUNDERBOLT IGBT[®]
 - Low voltage drop
 - Low tail current
 - Switching frequency up to 100 kHz
 - Soft recovery parallel diodes
 - Low diode VF
 - Low leakage current
 - Avalanche energy rated
 - RBSOA and SCSOA rated
- ISOTOP[®] Package (SOT-227)
- Very low stray inductance
- High level of integration

Benefits

- Outstanding performance at high frequency operation
- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive T_C of V_{CESat}
- RoHS Compliant

Absolute maximum ratings

| Symbol | Parameter | Max ratings | Unit |
|------------|---|------------------------------------|------|
| V_{CES} | Collector - Emitter Breakdown Voltage | 600 | V |
| I_{C1} | Continuous Collector Current | $T_C = 25^{\circ}C$ | A |
| I_{C2} | | $T_C = 90^{\circ}C$ | |
| I_{CM} | Pulsed Collector Current | $T_C = 25^{\circ}C$ | 160 |
| V_{GE} | Gate - Emitter Voltage | ± 20 | V |
| P_D | Maximum Power Dissipation | $T_C = 25^{\circ}C$ | 277 |
| I_{LM} | RBSOA clamped Inductive load Current $R_G = 11\Omega$ | $T_C = 25^{\circ}C$ | 100 |
| I_{FAV} | Maximum Average Forward Current | Duty cycle=0.5 $T_C = 80^{\circ}C$ | 30 |
| I_{FRMS} | RMS Forward Current (Square wave, 50% duty) | | 39 |

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

All ratings @ $T_j = 25^\circ\text{C}$ unless otherwise specified

Electrical Characteristics

| <i>Symbol</i> | <i>Characteristic</i> | <i>Test Conditions</i> | <i>Min</i> | <i>Typ</i> | <i>Max</i> | <i>Unit</i> |
|---------------|--------------------------------------|---|------------|------------|------------|---------------|
| I_{CES} | Zero Gate Voltage Collector Current | $V_{GE} = 0\text{V}$ | | | 40 | μA |
| | | $V_{CE} = 600\text{V}$ | | | 1000 | |
| $V_{CE(sat)}$ | Collector Emitter saturation Voltage | $V_{GE} = 15\text{V}$ | | 2.1 | 2.7 | V |
| | | $I_C = 50\text{A}$ | | 2.2 | 2.8 | |
| $V_{GE(th)}$ | Gate Threshold Voltage | $V_{GE} = V_{CE}, I_C = 700\mu\text{A}$ | 4.5 | 5.5 | 6.5 | V |
| I_{GES} | Gate – Emitter Leakage Current | $V_{GE} = \pm 20\text{V}, V_{CE} = 0\text{V}$ | | | ± 100 | nA |

Dynamic Characteristics

| <i>Symbol</i> | <i>Characteristic</i> | <i>Test Conditions</i> | <i>Min</i> | <i>Typ</i> | <i>Max</i> | <i>Unit</i> |
|---------------|------------------------------|---|------------|------------|------------|-------------|
| C_{ies} | Input Capacitance | $V_{GE} = 0\text{V}$ | | 2250 | | pF |
| C_{oes} | Output Capacitance | $V_{CE} = 25\text{V}$ | | 255 | | |
| C_{res} | Reverse Transfer Capacitance | $f = 1\text{MHz}$ | | 155 | | |
| Q_g | Total gate Charge | $V_{GS} = 15\text{V}$ | | 175 | | nC |
| Q_{ge} | Gate – Emitter Charge | $V_{Bus} = 300\text{V}$ | | 18 | | |
| Q_{gc} | Gate – Collector Charge | $I_C = 50\text{A}$ | | 100 | | |
| $T_{d(on)}$ | Turn-on Delay Time | Resistive Switching (25°C) | | 29 | | ns |
| T_r | Rise Time | $V_{GE} = 15\text{V}$ | | 118 | | |
| $T_{d(off)}$ | Turn-off Delay Time | $V_{Bus} = 300\text{V}$ | | 150 | | |
| T_f | Fall Time | $I_C = 50\text{A}$ | | 190 | | |
| $T_{d(on)}$ | Turn-on Delay Time | Inductive Switching (25°C) | | 30 | | ns |
| T_r | Rise Time | $V_{GE} = 15\text{V}$ | | 80 | | |
| $T_{d(off)}$ | Turn-off Delay Time | $V_{Bus} = 400\text{V}$ | | 240 | | |
| T_f | Fall Time | $I_C = 50\text{A}$ | | 43 | | |
| E_{ts} | Total switching Losses | $R_G = 10\Omega$ | | 3.6 | | mJ |
| $T_{d(on)}$ | Turn-on Delay Time | Inductive Switching (150°C) | | 28 | | ns |
| T_r | Rise Time | $V_{GE} = 15\text{V}$ | | 75 | | |
| $T_{d(off)}$ | Turn-off Delay Time | $V_{Bus} = 400\text{V}$ | | 265 | | |
| T_f | Fall Time | $I_C = 50\text{A}$ | | 185 | | |
| E_{on} | Turn-on Switching Energy | $R_G = 10\Omega$ | | 1.8 | | mJ |
| E_{off} | Turn-off Switching Energy | | | 2.4 | | |
| E_{ts} | Total switching Losses | | | 4.2 | | |

Chopper diode ratings and characteristics

| <i>Symbol</i> | <i>Characteristic</i> | <i>Test Conditions</i> | | <i>Min</i> | <i>Typ</i> | <i>Max</i> | <i>Unit</i> |
|------------------|----------------------------------|--|------------------------|------------|------------|------------|-------------|
| V _F | Diode Forward Voltage | I _F = 30A | | | 1.6 | 1.8 | V |
| | | I _F = 60A | | | 1.9 | | |
| | | I _F = 30A | T _j = 125°C | | 1.4 | | |
| I _{RM} | Maximum Reverse Leakage Current | V _R = 600V | T _j = 25°C | | | 250 | μA |
| | | V _R = 600V | T _j = 125°C | | | 500 | |
| C _T | Junction Capacitance | V _R = 200V | | | 44 | | pF |
| t _{rr} | Reverse Recovery Time | I _F =1A, V _R =30V di/dt = 100A/μs | T _j = 25°C | | 23 | | ns |
| | Reverse Recovery Time | | T _j = 25°C | | 85 | | |
| | | | T _j = 125°C | | 160 | | |
| I _{RRM} | Maximum Reverse Recovery Current | I _F = 30A V _R = 400V di/dt = 200A/μs | T _j = 25°C | | 4 | | A |
| | | | T _j = 125°C | | 8 | | |
| Q _{rr} | Reverse Recovery Charge | | T _j = 25°C | | 130 | | nC |
| | | | T _j = 125°C | | 700 | | |
| t _{rr} | Reverse Recovery Time | I _F = 30A | T _j = 125°C | | 70 | | ns |
| Q _{rr} | Reverse Recovery Charge | V _R = 400V | | | 1300 | | nC |
| I _{RRM} | Maximum Reverse Recovery Current | di/dt = 1000A/μs | | | 30 | | A |

Thermal and package characteristics

| <i>Symbol</i> | <i>Characteristic</i> | | <i>Min</i> | <i>Typ</i> | <i>Max</i> | <i>Unit</i> |
|-----------------------------------|---|-------|------------|------------|------------|-------------|
| R _{thJC} | Junction to Case Thermal Resistance | IGBT | | | 0.45 | °C/W |
| | | Diode | | | 1.21 | |
| R _{thJA} | Junction to Ambient (IGBT & Diode) | | | | 20 | |
| V _{ISOL} | RMS Isolation Voltage, any terminal to case t = 1 min, I _{isol} < 1mA, 50/60Hz | | 2500 | | | V |
| T _J , T _{STG} | Storage Temperature Range | | -55 | | 150 | °C |
| T _L | Max Lead Temp for Soldering: 0.063" from case for 10 sec | | | | 300 | |
| Torque | Mounting torque (Mounting = 8-32 or 4mm Machine and terminals = 4mm Machine) | | | | 1.5 | N.m |
| Wt | Package Weight | | | 29.2 | | g |

Typical IGBT Performance Curve

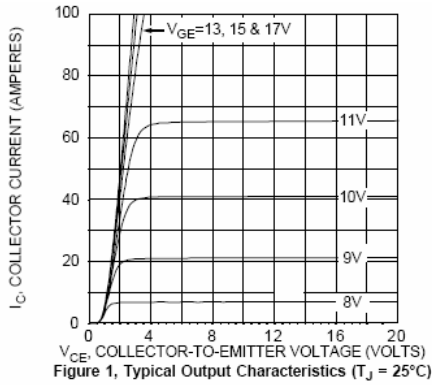


Figure 1, Typical Output Characteristics ($T_J = 25^\circ\text{C}$)

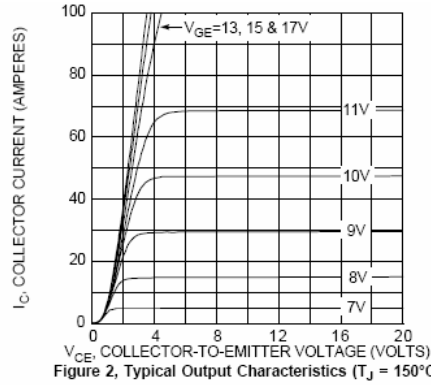


Figure 2, Typical Output Characteristics ($T_J = 150^\circ\text{C}$)

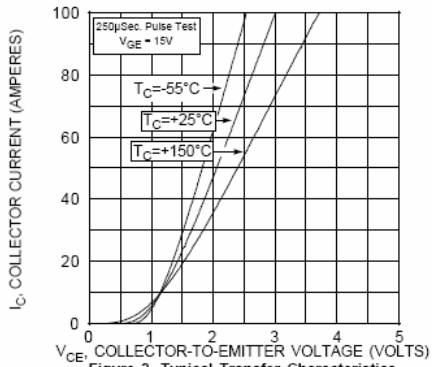


Figure 3, Typical Transfer Characteristics

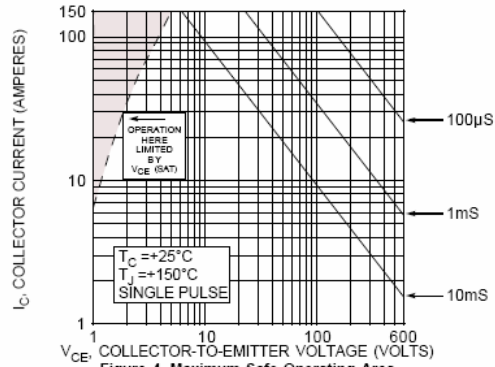


Figure 4, Maximum Safe Operating Area

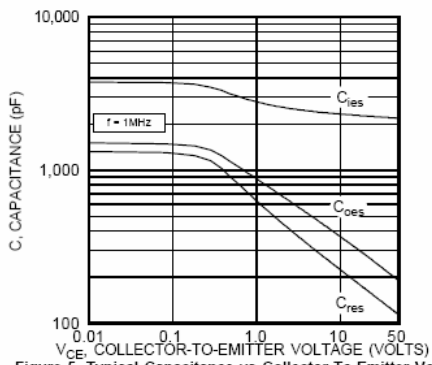


Figure 5, Typical Capacitance vs Collector-To-Emitter Voltage

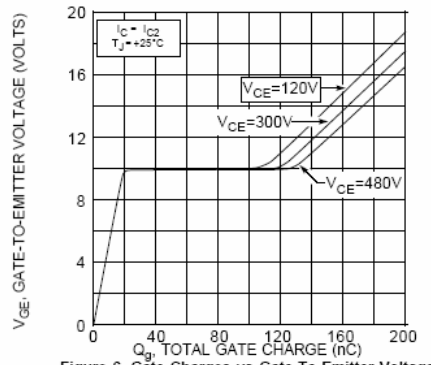


Figure 6, Gate Charges vs Gate-To-Emitter Voltage

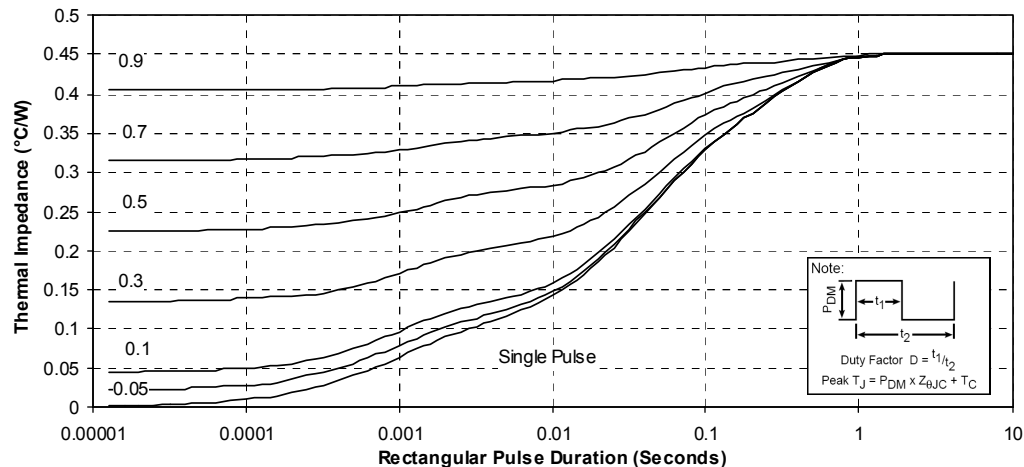


Figure 7, Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration

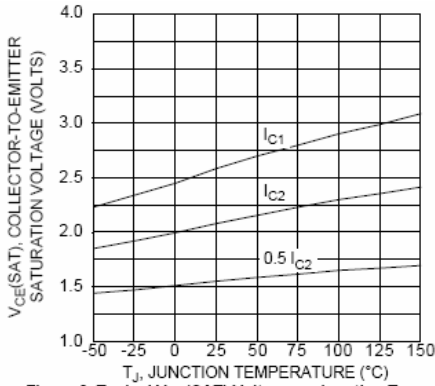


Figure 8, Typical $V_{CE(SAT)}$ Voltage vs Junction Temperature

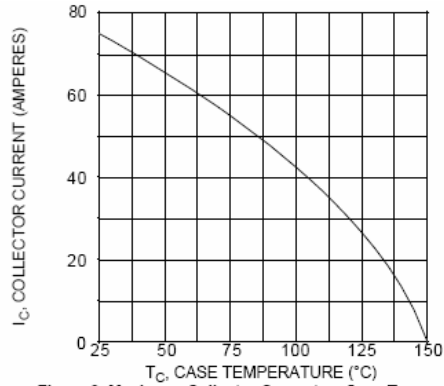


Figure 9, Maximum Collector Current vs Case Temperature

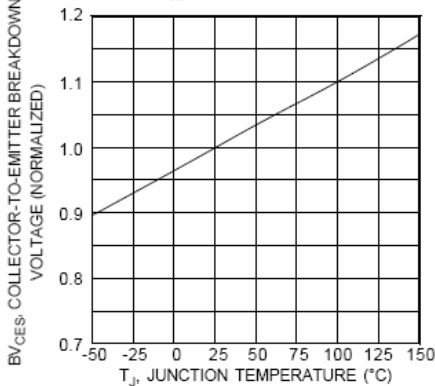


Figure 10, Breakdown Voltage vs Junction Temperature

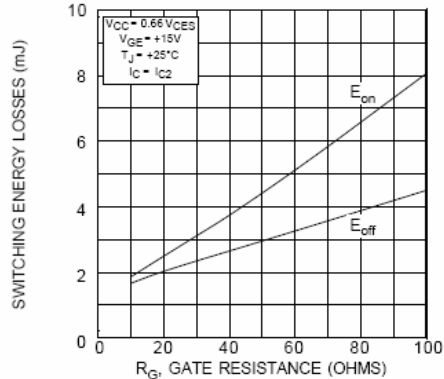


Figure 11, Typical Switching Energy Losses vs Gate Resistance

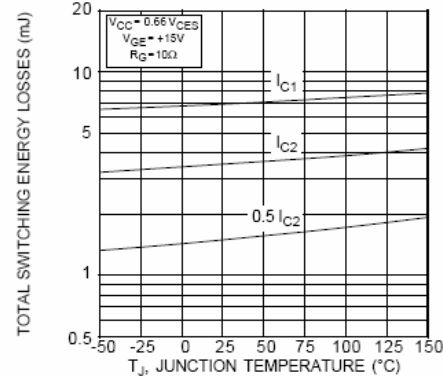


Figure 12, Typical Switching Energy Losses vs. Junction Temperature

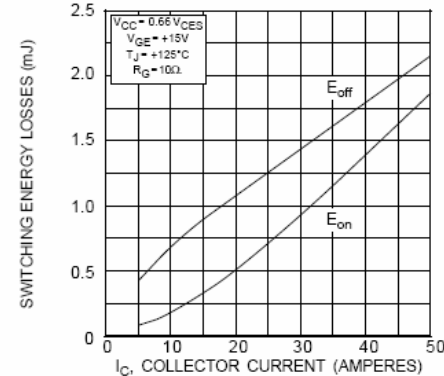


Figure 13, Typical Switching Energy Losses vs Collector Current

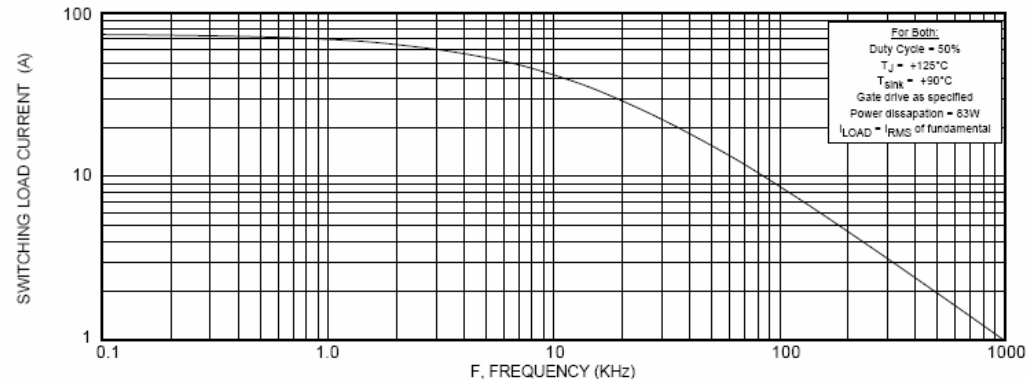


Figure 14, Typical Load Current vs Frequency

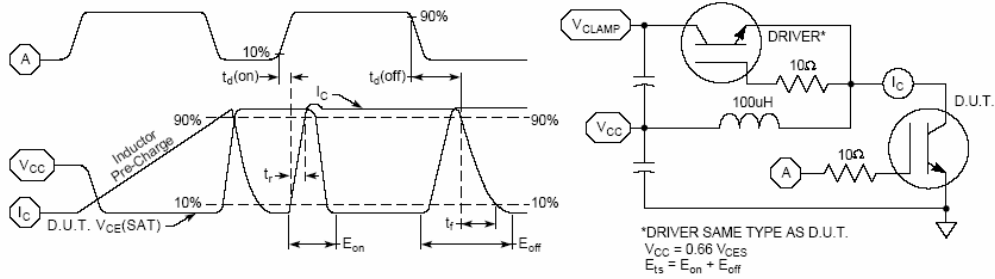


Figure 16, Switching Loss Test Circuit and Waveforms

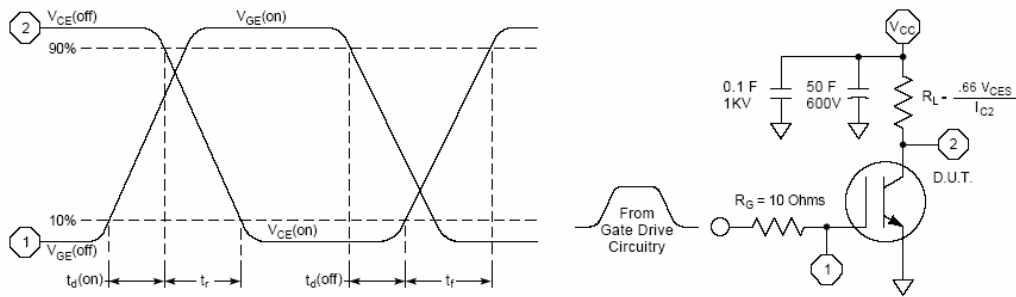


Figure 17, Resistive Switching Time Test Circuit and Waveforms

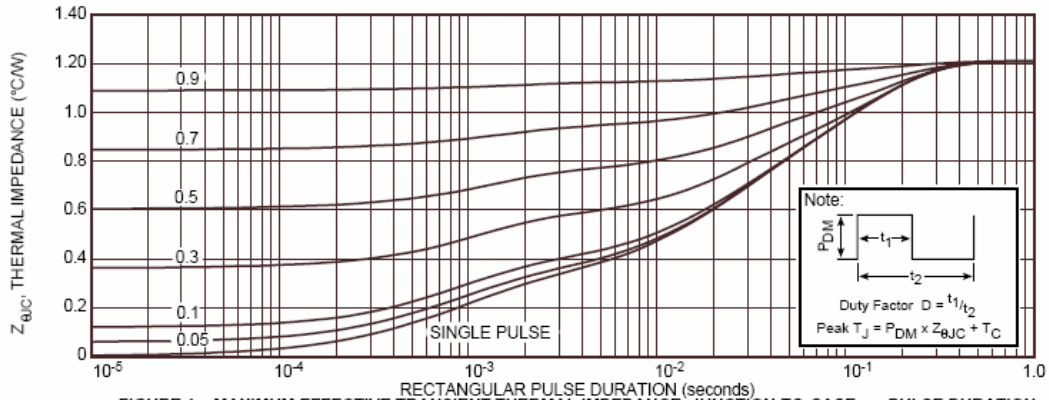
Typical Diode Performance Curve


FIGURE 1a. MAXIMUM EFFECTIVE TRANSIENT THERMAL IMPEDANCE, JUNCTION-TO-CASE vs. PULSE DURATION

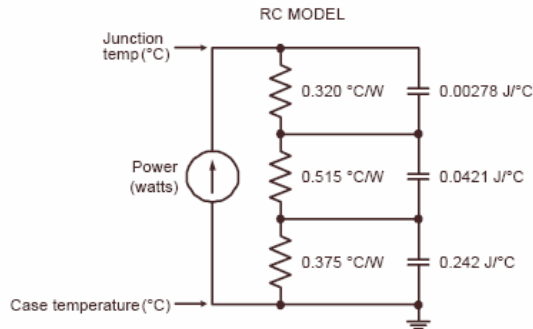


FIGURE 1b, TRANSIENT THERMAL IMPEDANCE MODEL

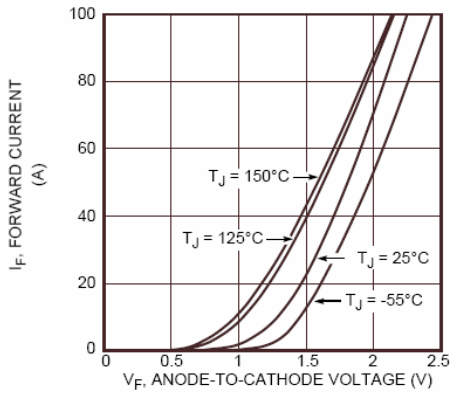


Figure 2. Forward Current vs. Forward Voltage

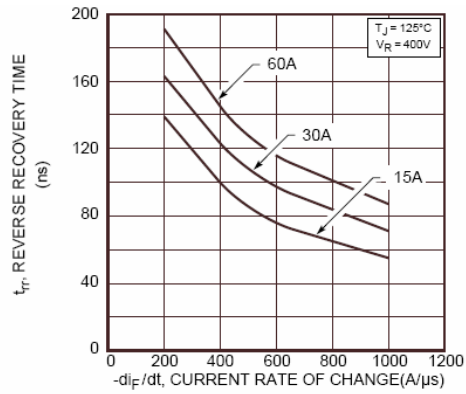


Figure 3. Reverse Recovery Time vs. Current Rate of Change

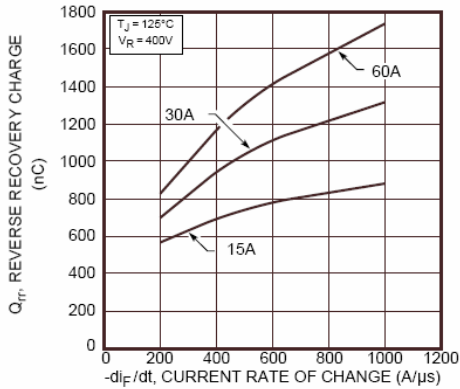


Figure 4. Reverse Recovery Charge vs. Current Rate of Change

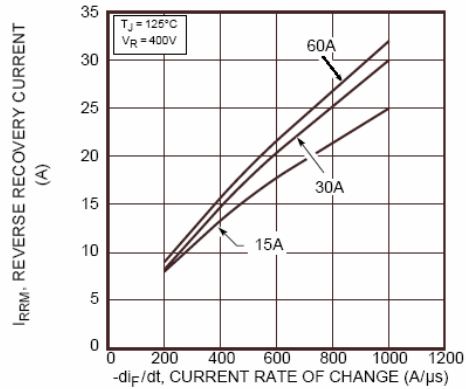


Figure 5. Reverse Recovery Current vs. Current Rate of Change

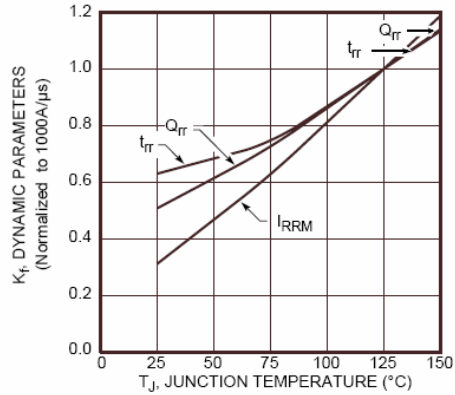


Figure 6. Dynamic Parameters vs. Junction Temperature

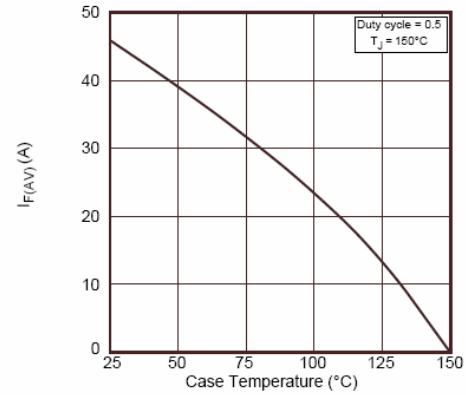


Figure 7. Maximum Average Forward Current vs. Case Temperature

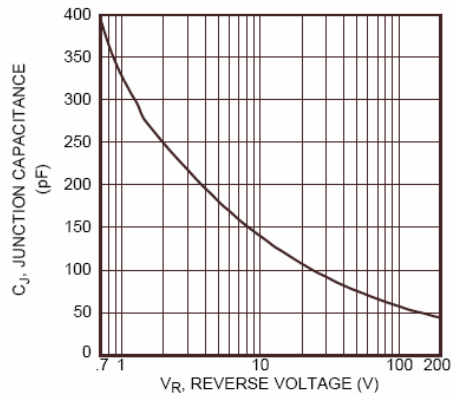


Figure 8. Junction Capacitance vs. Reverse Voltage

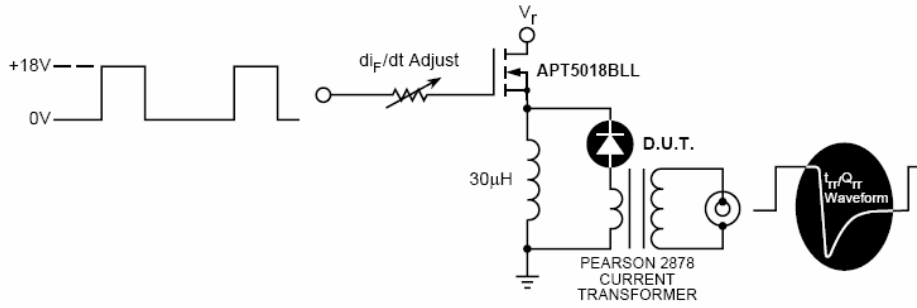


Figure 9. Diode Test Circuit

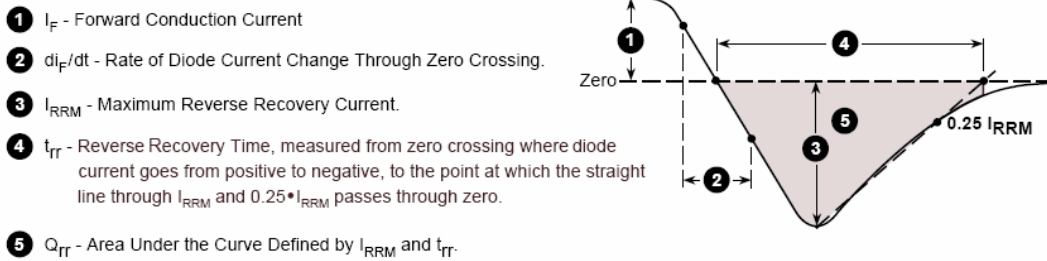
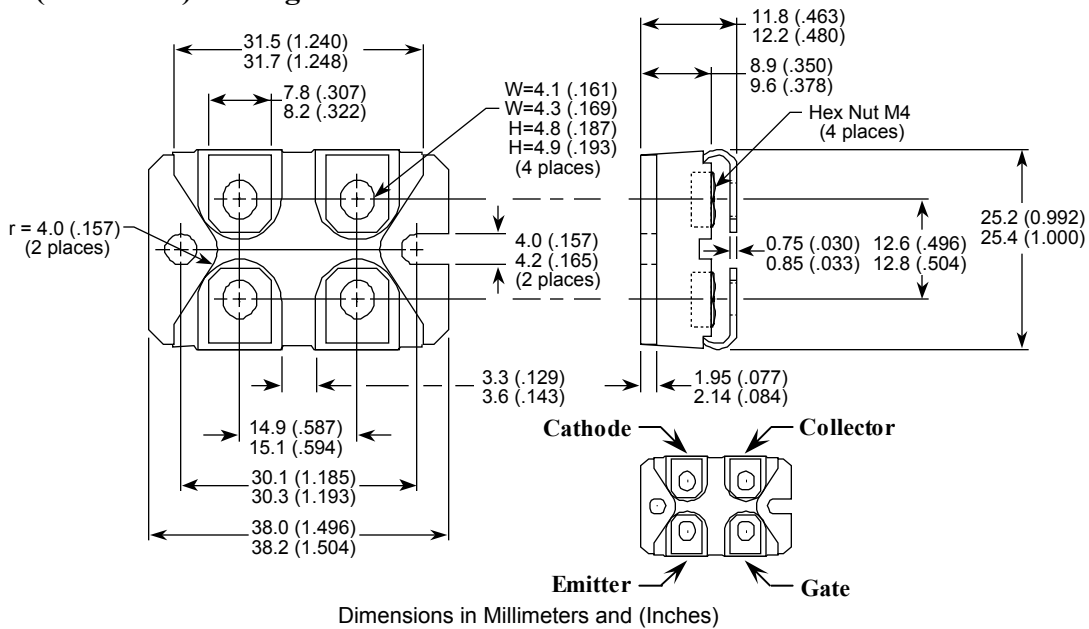


Figure 10. Diode Reverse Recovery Waveform and Definitions

SOT-227 (ISOTOP®) Package Outline



Dimensions in Millimeters and (Inches)

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Microsemi reserves the right to change, without notice, the specifications and information contained herein

Microsemi's products are covered by one or more of U.S. patents 4,895,810 5,045,903 5,089,434 5,182,234 5,019,522 5,262,336 6,503,786 5,256,583 4,748,103 5,283,202 5,231,474 5,434,095 5,528,058 and foreign patents. U.S. and Foreign patents pending. All Rights Reserved.